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## NTE5426

### Silicon Controlled Rectifier (SCR) Sensitive Gate

#### Description:

The NTE5426 is silicon controlled rectifier (SCR) in an isolated tab TO220 type package. This device may be switched from off-state to conduction by a current pulse applied to the gate terminal and is designed for control applications in lighting, heating, cooling, and static switching relays.

#### Absolute Maximum Ratings:

Repetitive Peak Off-State Voltage (Gate Open, $T_C = +110^\circ\text{C}$ ), $V_{\text{DRM}}$ .....	400V
Repetitive Peak Reverse Voltage (Gate Open, $T_C = +110^\circ\text{C}$ ), $V_{\text{RRM}}$ .....	400V
RMS On-State Current ( $T_C = +80^\circ\text{C}$ , 180° Conduction Angle), $I_{\text{T(RMS)}}$ .....	10A
Peak Surge (Non-Repetitive) On-State Current (One Cycle, 50 or 60Hz), $I_{\text{TSM}}$ .....	80A
Peak Gate-Trigger Current (3μs max), $I_{\text{GTM}}$ .....	1A
Peak Gate-Power Dissipation ( $I_{\text{GT}} = I_{\text{GTM}}$ ), $P_{\text{GM}}$ .....	16W
Average Gate Power Dissipation, $P_{\text{G(AV)}}$ .....	500mW
Operating Temperature Range, $T_{\text{opr}}$ .....	-40° to +100°C
Storage Temperature Range, $T_{\text{stg}}$ .....	-40° to +150°C
Typical Thermal Resistance, Junction-to-Case, $R_{\text{thJC}}$ .....	3.0°C/W

#### Electrical Characteristics: ( $T_C = +25^\circ\text{C}$ and “Maximum Ratings” unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Peak Off-State Current	$I_{\text{DRM}}, I_{\text{RRM}}$	Rated $V_{\text{DRM}}$ or $V_{\text{RRM}}$ , $T_C = +110^\circ\text{C}$ , RG – K = 1kΩ	–	–	0.1	mA
Maximum On-State Voltage	$V_{\text{TM}}$	$I_T$ = Rated Amps	–	–	2.0	V
Gate Trigger Current, Continuous DC	$I_{\text{GT}}$	Anode Voltage = 12V, $R_L = 60\Omega$	–	–	200	μA
Gate Trigger Voltage, Continuous DC	$V_{\text{GT}}$	Anode Voltage = 12V, $R_L = 60\Omega$	–	–	0.8	V
DC Holding Current	$I_H$	Gate Open, RG – K = 1kΩ	–	–	3.0	mA
Turn-On Time	$t_{\text{gt}}$	$(t_d + t_r) I_{\text{GT}} = 150\text{mA}$	–	–	2.5	μs
Critical Rate of Rise of Off-State Voltage	critical dv/dt	Gate Open, $T_C = +110^\circ\text{C}$ , RG – K = 1kΩ	–	8	–	V/μs

